

37-40GHz Integrated Down Converter

GaAs Monolithic Microwave IC in SMD leadless package

Description

The CHR3894-QEG is a multifunction monolithic receiver, which integrates a balanced cold FET mixer, a LO chain with buffers associated to a time two multiplier, and a RF low noise amplifier including gain control.

It is designed for a wide range of applications, from military to commercial communication systems.

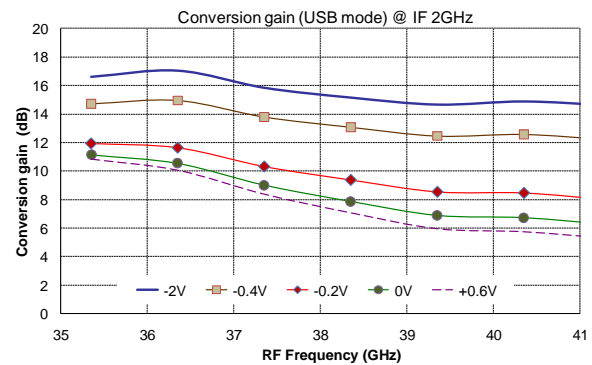
The circuit is manufactured with a pHEMT process, 0.15 μ m gate length, via holes through the substrate, air bridges and electron beam gate lithography.

It is supplied in RoHS compliant SMD package.



Main Features

- Broadband performances: 37-40GHz
- 13dB Conversion gain
- 15dBc Image Rejection
- 2dBm IIP3 without attenuation (GC=-2V)
- 8dB Gain Control range
- 4dB Noise Figure for IF>0.1GHz
- 0dBm LO input Power
- DC bias: Vd=4V @ Id=250mA
- 24L-QFN4x5
- MSL1



Main Electrical Characteristics

Tamb.= +25°C

Symbol	Parameter	Min	Typ	Max	Unit
F _{RF}	RF frequency range	37		40	GHz
F _{LO}	LO frequency range	17.5		21.0	GHz
F _{IF}	IF frequency range	DC		3.5	GHz
G	Conversion gain without attenuation	10	13		dBm

Electrical Characteristics

Tamb.= +25°C, VD = VD1 = +4V (1)

Symbol	Parameter	Min	Typ	Max	Unit
F _{RF}	RF frequency range	37		40	GHz
F _{LO}	LO frequency range	17.5		21.0	GHz
F _{IF}	IF frequency range	DC		3.5	GHz
G	Conversion gain without attenuation ⁽²⁾	10	13		dB
ΔG	Gain control range		8		dB
NF	Noise Figure for IF>0.1GHz		4	4.5	dB
Im_rej	Image rejection ⁽²⁾	12	15		dBc
P _{LO}	LO Input power		0		dBm
IIP3	Input IP3 without attenuation	0	2		dBm
IIP3	Input IP3 @ all attenuations	-2	0		dBm
LO RL	LO return loss		-12		dB
RF RL	RF return loss		-7		dB
VGL	LNA DC gate voltage		-0.1		V
VGX	Multiplier DC gate voltage		-0.9		V
GC	Gain control DC voltage	-2		+0.6	V
IDt	Total Drain current (ID+ID1) ⁽³⁾		250		mA

These values are representative of onboard measurements as defined on the drawing in paragraph "Evaluation mother board".

(1) VD: LO-chain drain bias voltage. VD1: LNA drain bias voltage.

(2) An external combiner 90° is required on I / Q.

(3) ID: LO-chain drain current, typically 125mA.

(3) ID1: LNA drain current, typically 125mA, should be tuned with VGL.

Note: The total current (IDt) is not affected by the gain control voltage (GC).

Electrostatic discharge sensitive device observe handling precautions!

Absolute Maximum Ratings ⁽¹⁾T_{amb.} = +25°C

Symbol	Parameter	Values	Unit
VD, VD1	Drain bias voltages	4.5V	V
IDt	Drain bias current	340	mA
VGL, VGX	Gate bias voltages	-2 to +0.4	V
GC	Gain Control voltage	-2.5 to +0.8	V
P_RF	Maximum peak input power overdrive ⁽²⁾	+15	dBm
P_LO	Maximum LO input power	+15	dBm
Tj	Junction temperature ⁽²⁾	175	°C
Ta	Operating temperature range	-40 to +85	°C
Tstg	Storage temperature range	-55 to +150	°C

⁽¹⁾ Operation of this device above anyone of these parameters may cause permanent damage.

⁽²⁾ Duration < 1s.

Typical Bias ConditionsT_{amb.} = +25°C

Symbol	Pad N°	Parameter	Values	Unit
VD1, VD	10, 11	DC drain voltages (LNA and LO-chain)	4	V
ID1	10	LNA drain current controlled with VGL	125	mA
VGL	9	LNA DC gate voltage	-0.1	V
VGX	12	Multiplier DC gate voltage	-0.9	V
GC	8	Gain control DC voltage	-2 to 0.6	V

Device thermal performances

All the figures given in this section are obtained assuming that the QFN device is cooled down only by conduction through the package thermal pad (no convection mode considered). The temperature is monitored at the package back-side interface (Tcase) as shown below. The system maximum temperature must be adjusted in order to guarantee that Tcase remains below than the maximum value specified in the next table. So, the system PCB must be designed to comply with this requirement.

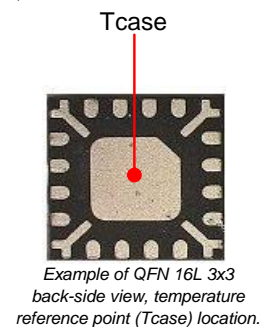
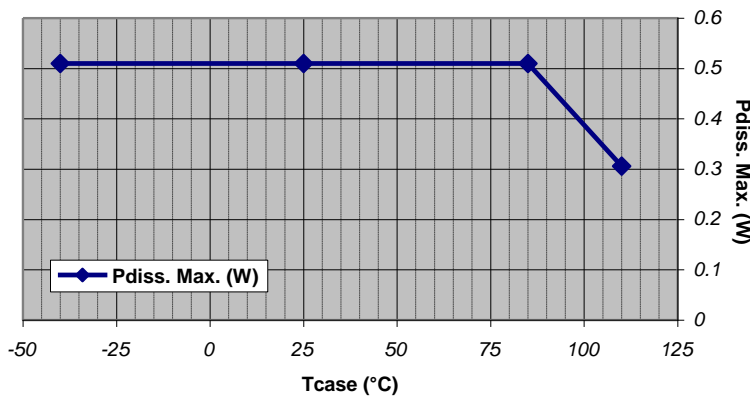
A derating must be applied on the dissipated power if the Tcase temperature can not be maintained below than the maximum temperature specified (see the curve P_{diss. Max}) in order to guarantee the nominal device life time (MTTF).

DEVICE THERMAL SPECIFICATION : CHR3894-QEG	
Recommended max. junction temperature (T _j max)	: 147 °C
Junction temperature absolute maximum rating	: 175 °C
Max. continuous dissipated power @ T _{case} = 85 °C	: 0.51 W
=> P _{diss} derating above T _{case} ⁽¹⁾ = 85 °C	: 8 mW/°C
Junction-Case thermal resistance (R _{th J-C}) ⁽²⁾	: <122 °C/W
Min. package back side operating temperature ⁽³⁾	: -40 °C
Max. package back side operating temperature ⁽³⁾	: 85 °C
Min. storage temperature	: -55 °C
Max. storage temperature	: 150 °C

(1) Derating at junction temperature constant = T_j max

(2) R_{th J-C} is calculated for a worst case where the **hotter junction** of the MMIC is considered.

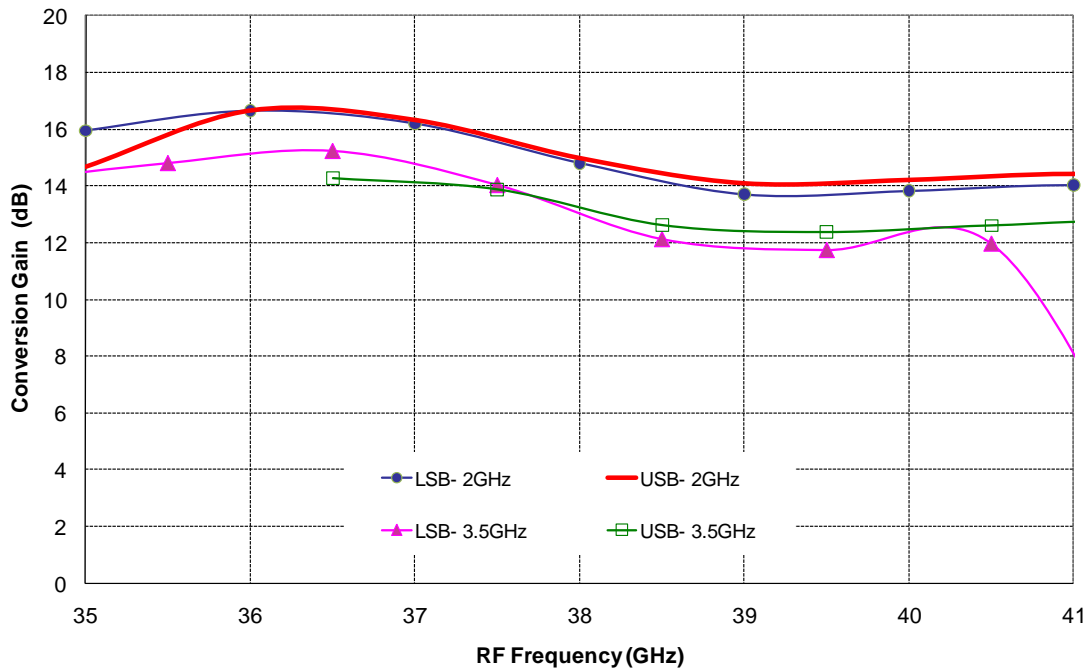
(3) T_{case}=Package back side temperature measured under the die-attach-pad (see the drawing below).



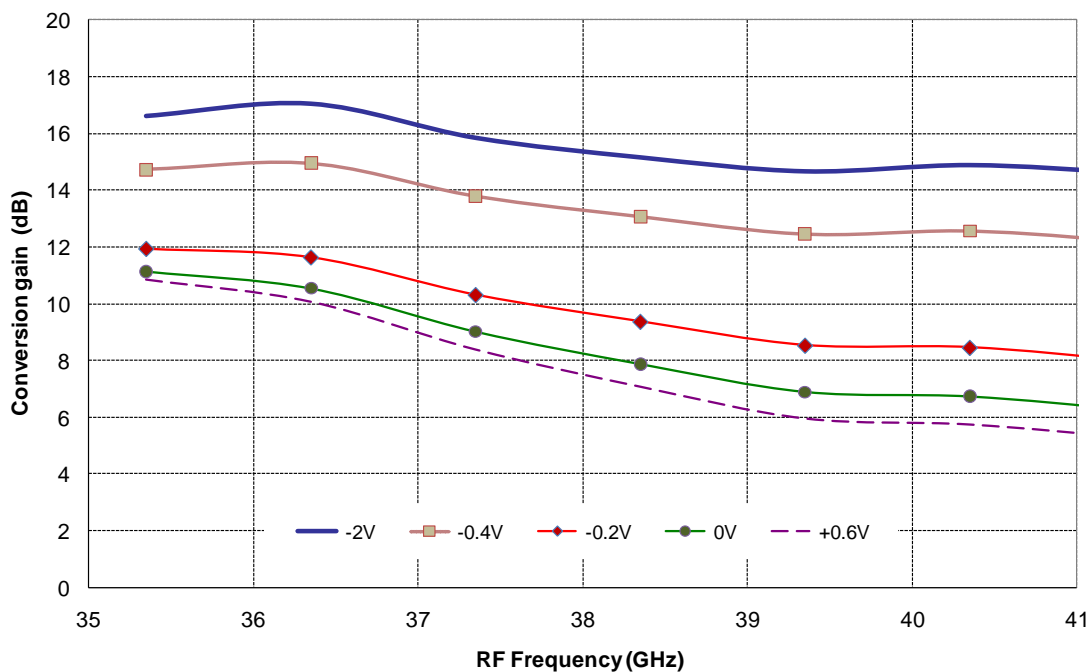
Typical Board Measurements

Tamb.= +25°C, VD = VD1 =+4V, VGL = -0.1V, VGX = -0.9V, P_LO = 0dBm (IDt = 250mA)
 These values are representative of onboard measurements as defined on the drawing in paragraph "Evaluation mother board". Data given in the package access planes.

Conversion Gain versus RF & IF frequency (USB & LSB modes)
 without attenuation: GC= -2V



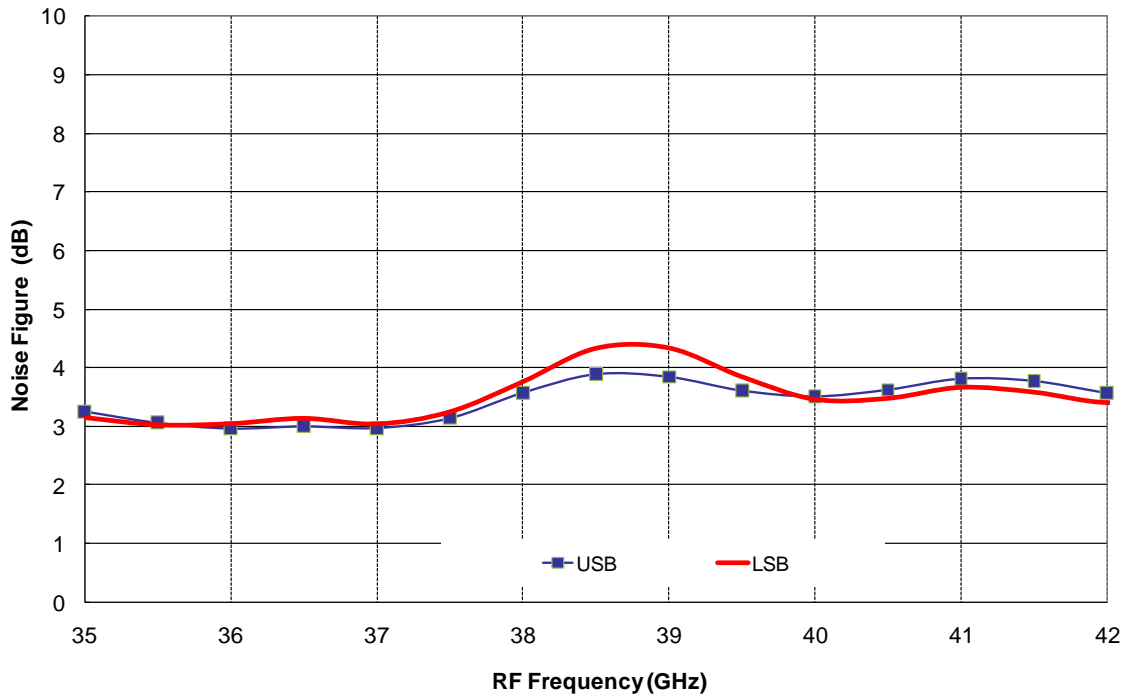
Conversion Gain versus RF frequency and gain control voltage
 (IF 2GHz, USB mode)



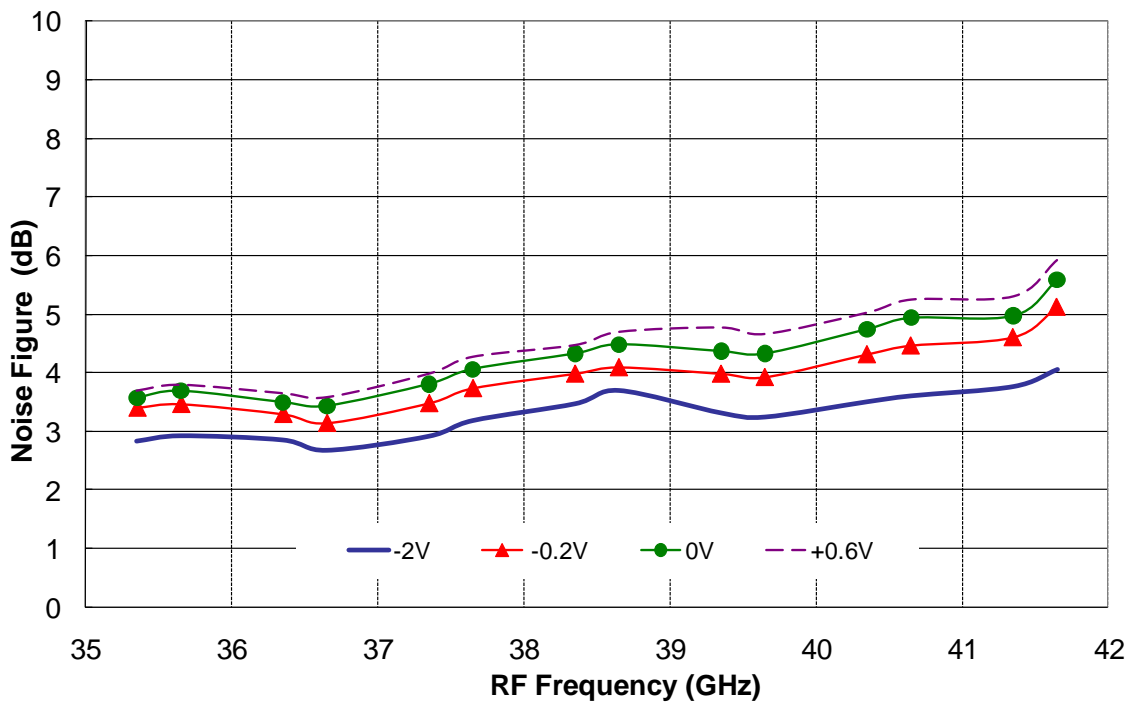
Typical Board Measurements

Tamb.= +25°C, VD = VD1 = +4V, VGL = -0.1V, VGX = -0.9V, P_LO = 0dBm (IDt = 250mA)

Noise figure versus RF frequency at IF 2GHz (USB & LSB modes)
without attenuation: GC= -2V



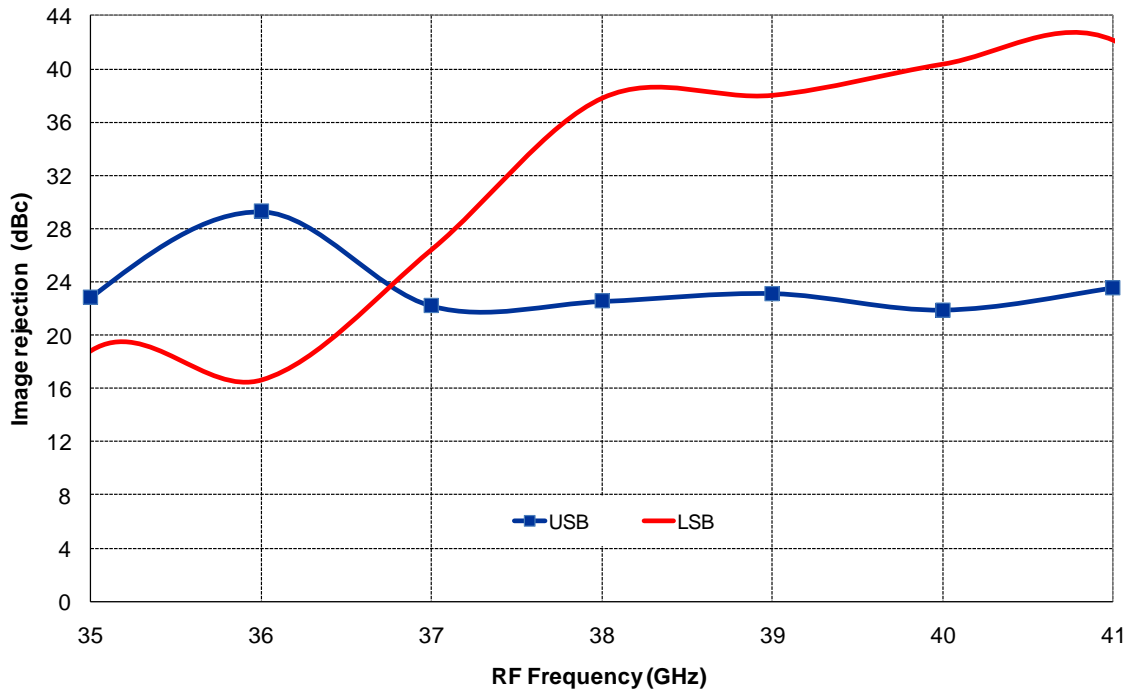
Noise figure versus gain control range (IF 2GHz, USB mode)



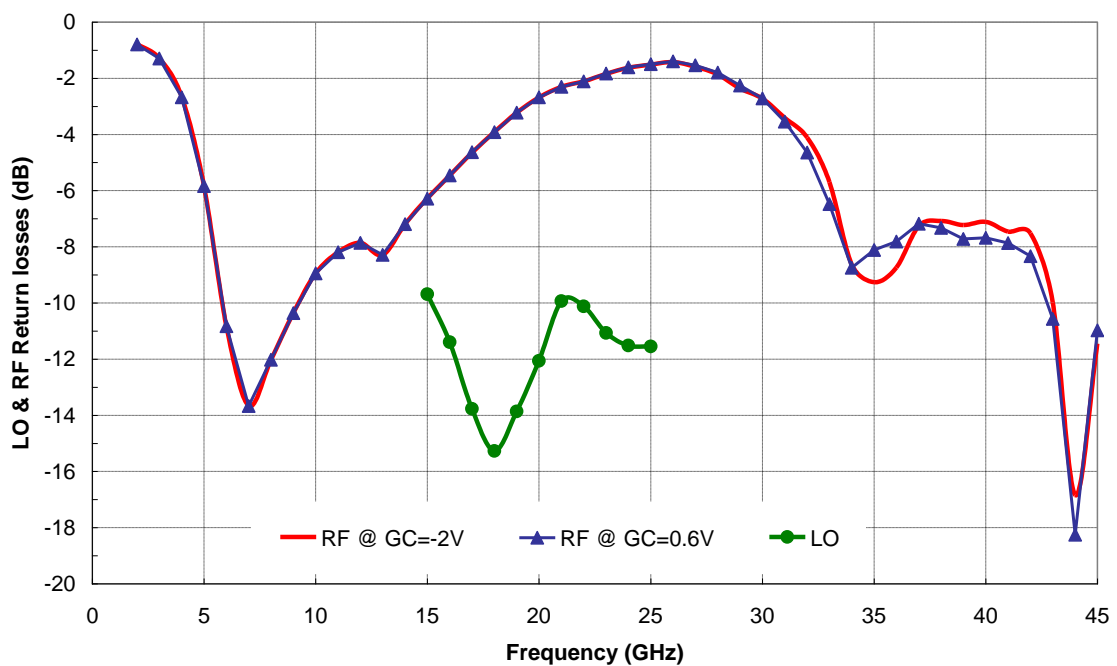
Typical Board Measurements

Tamb.= +25°C, VD = VD1 = +4V, VGL = -0.1V, VGX = -0.9V, P_LO = 0dBm (IDt = 250mA)

Image rejection versus RF frequency at IF 2GHz (USB & LSB modes)
without attenuation: GC= -2V



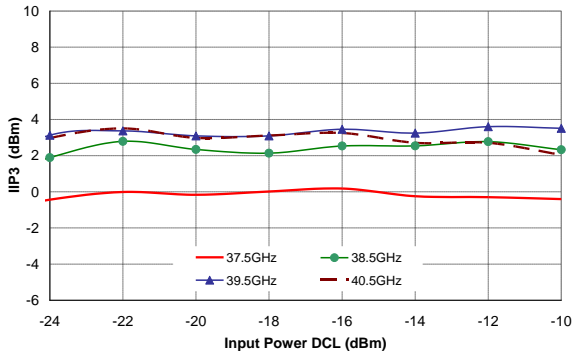
Return Losses (LO & RF) versus frequency and gain control voltage



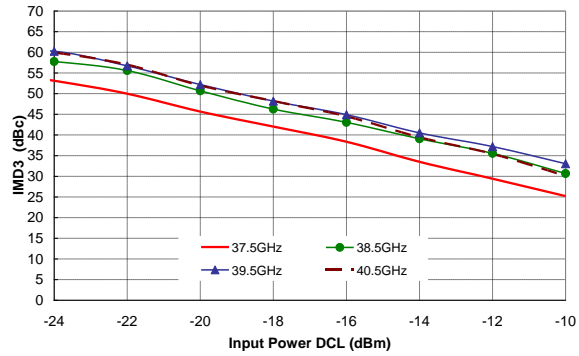
Typical Board Measurements

Tamb.= +25°C, VD = VD1 = +4V, VGL = -0.1V, VGX = -0.9V, P_LO = 0dBm (IDt = 250mA)

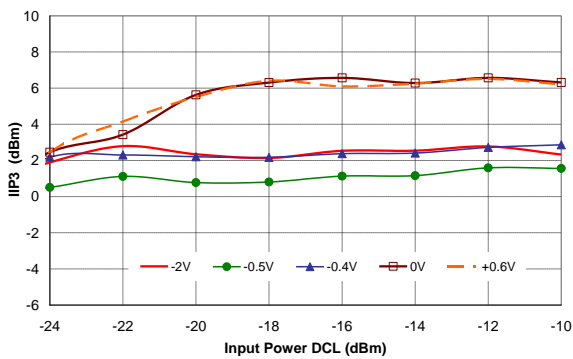
Input IP3 vs RF frequency at IF 3.5GHz
without attenuation: GC= -2V



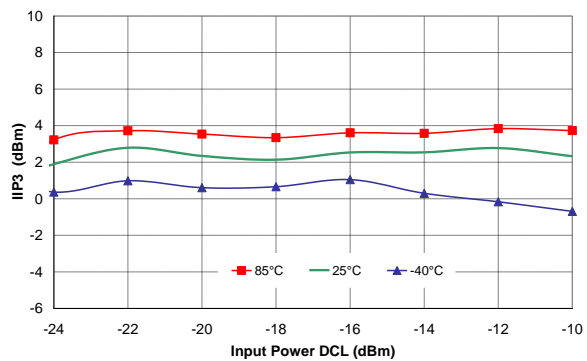
IMD3 vs RF frequency at IF 3.5GHz
without attenuation: GC= -2V



Input IP3 vs gain control at 38.5GHz



Input IP3 vs temperature at 38.5GHz
without attenuation: GC= -2V

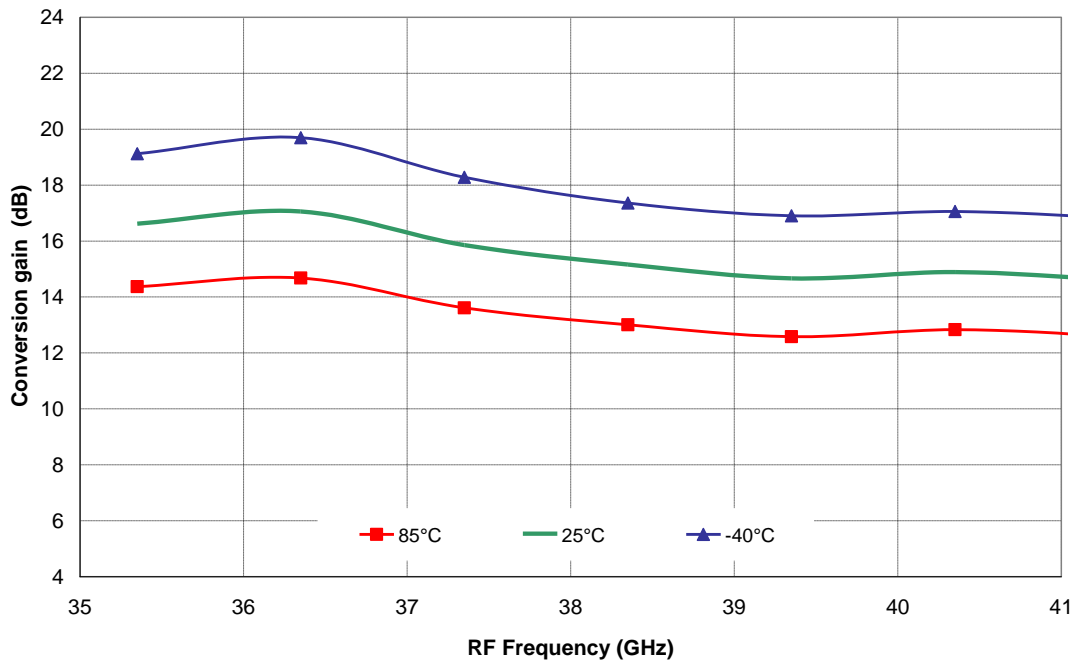


Typical Board Measurements

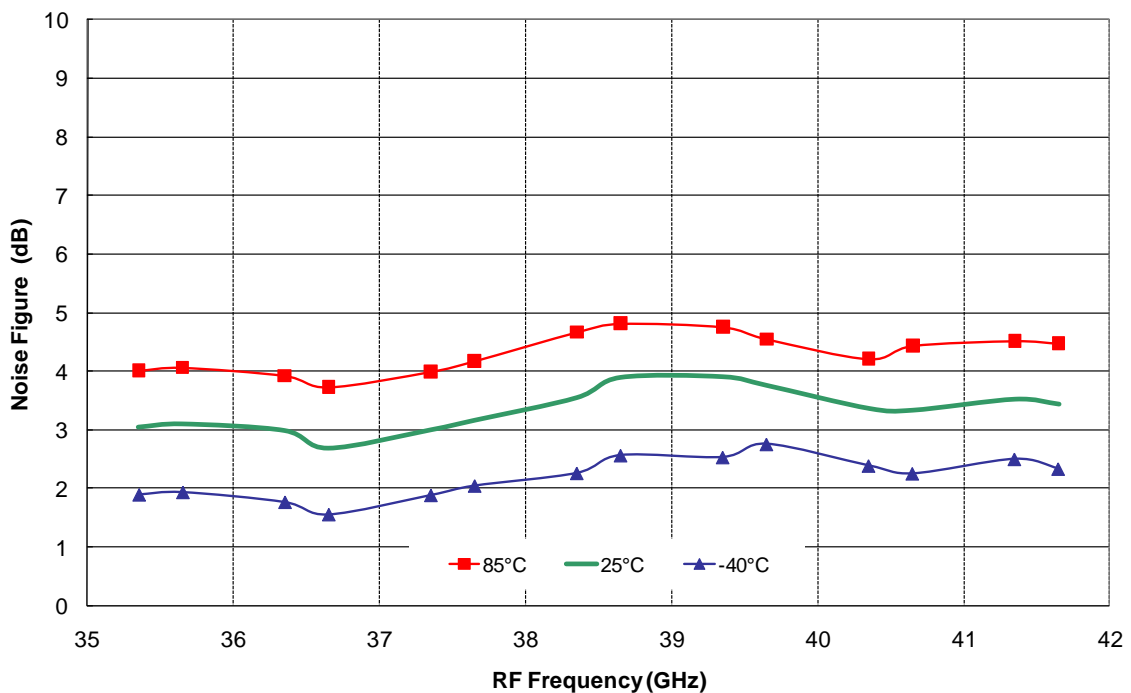
Tamb = +25°C, Tcold = -40°C, Thot = +85°C

VD = VD1 = +4V, VGL = -0.1V, VGX = -0.9V, P_LO = 0dBm

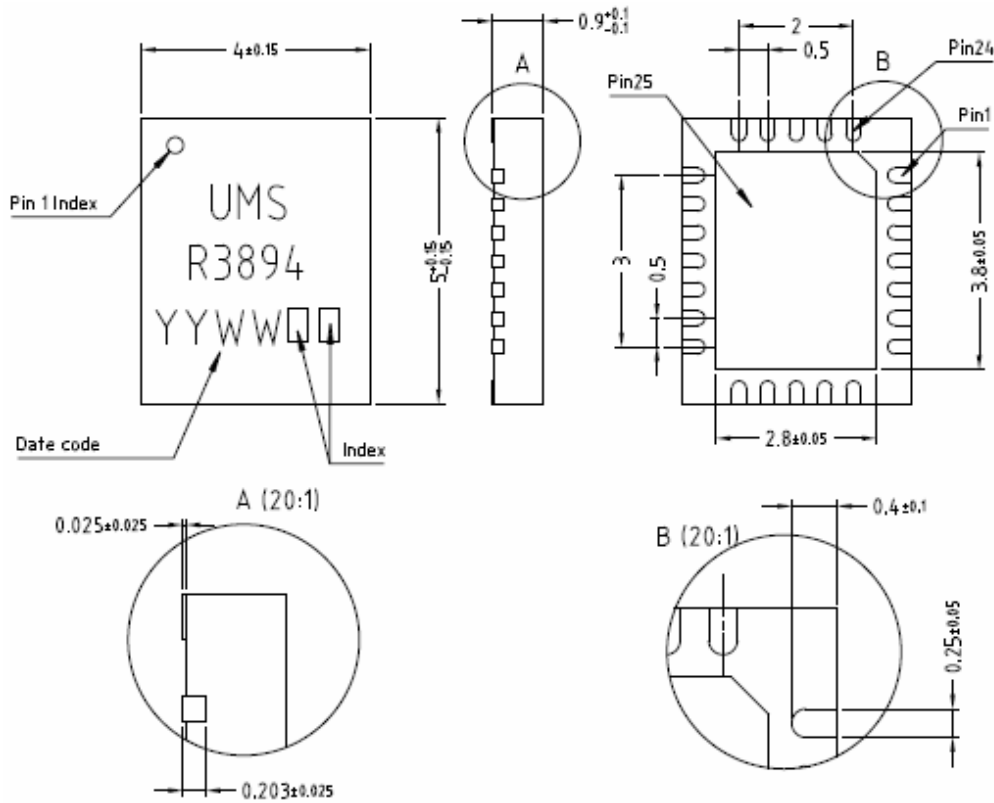
Conversion Gain versus temperature at IF 2GHz (USB mode)
without attenuation: GC= -2V



Noise figure versus temperature at IF 2GHz (USB mode)
without attenuation: GC= -2V



Package outline ⁽¹⁾



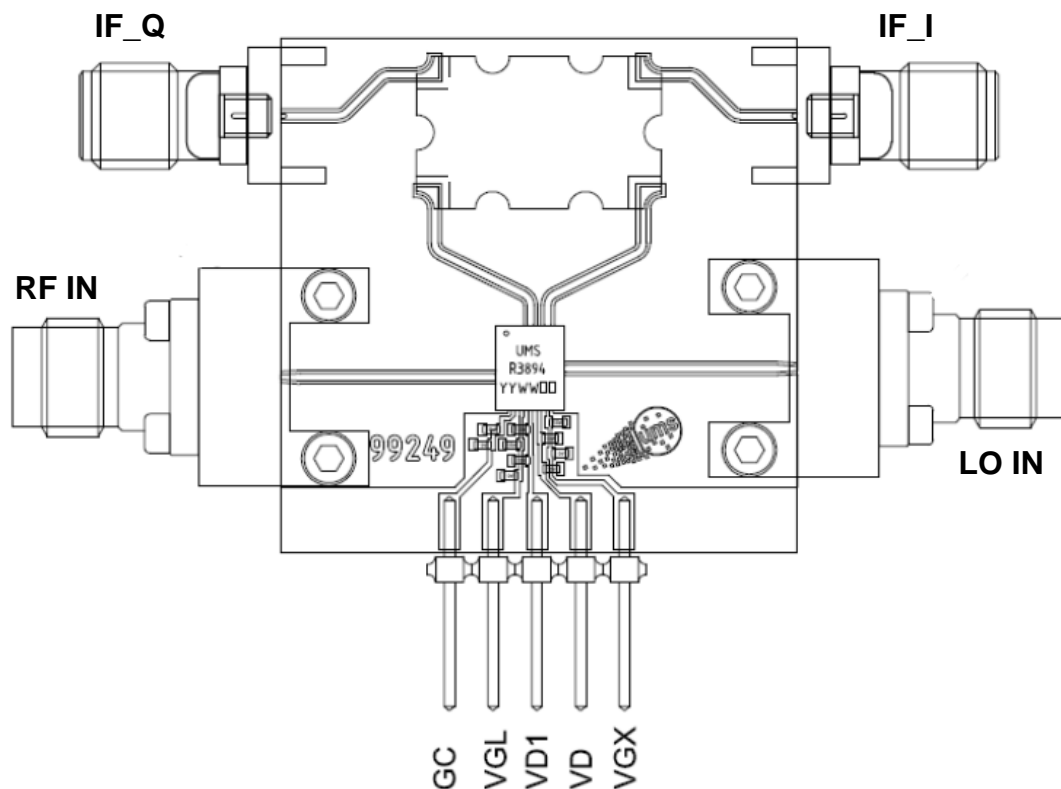
Matt tin, Lead Free (Green)	1- Nc	9- VGL	17- Gnd ⁽²⁾
Units : mm	2- Nc	10- VD1	18- Nc
From the standard : JEDEC MO-220	3- Nc	11- VD	19- Nc
(VGGD)	4- Gnd ⁽²⁾	12- VGX	20- IF_I
25- GND	5- RF in	13- Nc	21- Gnd ⁽²⁾
	6- Gnd ⁽²⁾	14- Nc	22- IF_Q
	7- Nc	15- Gnd ⁽²⁾	23- Nc
	8- GC	16- LO in	24- Nc

⁽¹⁾ The package outline drawing included to this data-sheet is given for indication. Refer to the application note AN0017 (<http://www.ums-gaas.com>) for exact package dimensions.

⁽²⁾ It is strongly recommended to ground all pins marked "Gnd" through the PCB board. Ensure that the PCB board is designed to provide the best possible ground to the package.

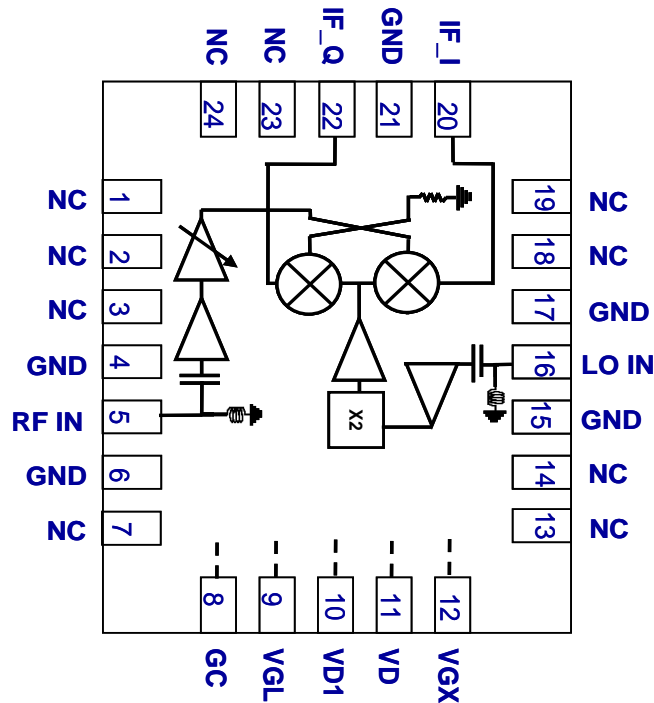
Evaluation mother board

- Compatible with the proposed footprint.
- Based on typically Ro4003 / 8mils or equivalent.
- Using a micro-strip to coplanar transition to access the package.
- Recommended for the implementation of this product on a module board.
- Decoupling capacitors of 10nF \pm 10% are recommended for all DC accesses.
- See application note AN0017 for details.
- Hybrid coupler 90° for 2-4GHz.



Notes

Due to ESD protection circuits on RF input and output, an external capacitance might be requested to isolate the product from external voltage that could be present on the RF accesses.



ESD protections are also implemented on gate and control accesses.

The DC connections do not include any decoupling capacitor in package, therefore it is mandatory to provide a good external DC decoupling (10nF) on the PC board, as close as possible to the package.

Recommended package footprint

Refer to the application note AN0017 available at <http://www.ums-gaas.com> for package footprint recommendations.

SMD mounting procedure

For the mounting process standard techniques involving solder paste and a suitable reflow process can be used. For further details, see application note AN0017.

Recommended environmental management

UMS products are compliant with the regulation in particular with the directives RoHS N°2011/65 and REACH N°1907/2006. More environmental data are available in the application note AN0019 also available at <http://www.ums-gaas.com>.

Recommended ESD management

Refer to the application note AN0020 available at <http://www.ums-gaas.com> for ESD sensitivity and handling recommendations for the UMS package products.

Ordering Information

QFN 4x4 package:

CHR3894-QEG/XY

Stick: XY = 20

Tape & reel: XY = 21

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